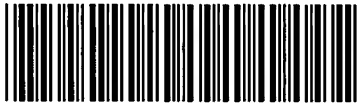


<b>Search Notes</b>  	<b>Application/Control No.</b>  10559662	<b>Applicant(s)/Patent Under Reexamination</b>  NAKAMURA ET AL.
	<b>Examiner</b>  La Barr, Edward T	<b>Art Unit</b>  2609

SEARCHED			
Class	Subclass	Date	Examiner
345	473	3/16/2007	Edward T. La Barr
345		3/19/2007	Edward T. La Barr
345		2/27/2007	Edward T. La Barr
345		3/28/2007	Edward T. La Barr
345		3/29/2007	Edward T. La Barr
345		3/30/2007	Edward T. La Barr
345		4/2/2007	Edward T. La Barr
345		4/4/2007	Edward T. La Barr
715		4/5/2007	Edward T. La Barr
345		11/2/2007	ETL

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search	3/16/2007	Edward T. La Barr
Text Search (See File)	11/2/2007	ETL
Consult - Xiao Wu (SPE)	11/8/2007	ETL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner